

**Search Notes**

Application/Control No.

10/588,401

Examiner

CHRIS C. CHU

Applicant(s)/Patent under  
Reexamination

BIRZER ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	E27.137, E27.144 & E27.161	8/3/2008	C.C.
257	723 & 724	8/3/2008	C.C.
257	685 & 686	8/3/2008	C.C.
257	777	8/3/2008	C.C.
438	108 & 109	8/3/2008	C.C.
361	760	8/3/2008	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; and IBM_TDB;	8/3/2008	C.C.